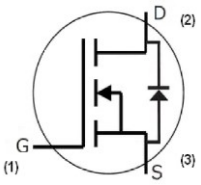
1200V 75mΩ Silicon Carbide Power MOSFET

Features

- AEC-Q101 qualified
- High blocking voltage with low on-resistance
- High switching speed with low capacitance
- Very fast and robust intrinsic body diode with low reverse recovery
- Very low switching losses
- Excellent avalanche ruggedness
- RoHS compliant

Benefits



- Greater system efficiency
- Reduced cooling requirements
- Increased power density
- Increased system switching frequency
- Easy to parallel and simple to drive

Potential Applications

Package Type: TO-247-3L

- Solar inverters
- Uninterrupted power supplies
- Switch mode power supplies
- Motor drives

Description

The Sanan Semiconductor 1200V/75mΩ silicon carbide power MOSFET uses advanced SiC MOSFET technology with low on-resistance, low switching losses, and a high operation temperature of 175℃. It is suitable for use in high frequency circuits and provides a reduction in overall system size, increased efficiency and increased switching frequency. It has been widely used in applications including solar inverters, uninterrupted power supplies, switch mode power supplies, and motor drives. Using RoHS compliant components and being AEC-Q101 qualified, it is qualified for use in industrial application.

Product Specifications

Device	V_{DS}	I_D (25℃)	$R_{(DS)on}$	Marking
AMS1200075K	1200V	35A	75mΩ	MS1200075K

CONTENTS

Table 1. Maximum Ratings

(T_C = 25℃, unless otherwise specified)

Parameter	Symbol	Value	Unit	Test conditions
Drain-source voltage	V_{DSmax}	1200	V	V_{GS} = 0V, I_D = 100μA
Gate-source voltage, max. transient voltage	V_{GSmax}	-10/+22		$t_p \leq$ 0.5us, D <1%
Gate-source voltage, max. static voltage	V_{GSmax}	-8/+19		
Gate-source voltage	V_{GSop}	-4/+15		Recommended operation values,
Continuous drain current	I_D	35	A	V_{GS} = 15V
		25		V_{GS} = 15V, T_C = 100℃
Pulsed drain current	$I_{D(pulse)}$	88	A	Pulse width t_p limited by T_{jmax}
Power dissipation	P_{tot}	208	W	
Operating junction temperature	T_j	-55~175	℃	
Storage temperature	T_{stg}	-55~175	℃	
Soldering temperature	T_L	260	℃	1.6mm from case for 10s
Mounting torque	M	0.7	Nm	M3 screw

Table 2. Thermal Resistances

Parameter	Symbol	Values			Unit	Test condition
		Min.	Typ.	Max.		
Thermal resistance from junction to case	$R_{th(j-c)}$	/	0.60	/	℃/W	
Thermal resistance from junction to ambient	$R_{th(j-a)}$	/	/	40	℃/W	

Table 3. Static Electrical Characteristics

(T_j = 25℃, unless otherwise specified)

Parameter	Symbol	Values			Unit	Test conditions
		Min.	Typ.	Max.		
Drain-source breakdown voltage	$V_{(BR)DSS}$	1200	/	/	V	V_{GS} = 0V, I_D = 100μA
Gate threshold voltage	$V_{GS(th)}$	1.8	2.8	4		V_{DS} = V_{GS}, I_D = 5mA
		/	2.0	/		V_{DS} = V_{GS}, I_D = 5mA, T_j = 175℃
Drain-source leakage current	I_{DSS}	/	1	100	μA	V_{DS} = 1200V, V_{GS} = 0V
Gate-source leakage current	I_{GSS}	/	1	250	nA	V_{GS} = 15V, V_{DS} = 0V
Drain-source on-state resistance	$R_{DS(on)}$	/	75	92	mΩ	V_{GS} = 15V, I_D = 18A
		/	110	/		V_{GS} = 15V, I_D = 18A, T_j = 175℃
Transconductance	g_{fs}	/	13	/	S	V_{DS} = 20V, I_D = 18A
		/	12	/		V_{DS} = 20V, I_D = 18A, T_j = 175℃
Internal gate resistance	$R_{g(int)}$	/	1.9	/	Ω	f = 1MHz, V_{AC} = 25mV

Table 4. Dynamic Electrical Characteristics

(T_j = 25℃, unless otherwise specified)

Parameter	Symbol	Values			Unit	Test conditions
		Min.	Typ.	Max.		
Input capacitance	C_{iss}	/	1484	/	pF	V_{GS} = 0V, V_{DS} = 1000V, f = 1MHz, V_{AC} = 25mV
Output capacitance	C_{oss}	/	79	/		
Reverse transfer capacitance	C_{rss}	/	1	/		
C_{OSS} stored energy	E_{oss}	/	44	/	μJ	
Gate to source charge	Q_{GS}	/	18	/	nC	V_{DD} = 800V, I_D = 18A, V_{GS} = -4/+15V, I_{GS} = 1mA
Gate to drain charge	Q_{GD}	/	20	/		
Total gate charge	Q_G	/	58	/		

Table 5. Switching Characteristics

(T_j = 25℃, unless otherwise specified)

Parameter	Symbol	Values			Unit	Test conditions
		Min.	Typ.	Max.		
Turn-on delay time	$t_{d(on)}$	/	32	/	ns	V_{DD} = 800V, V_{GS} = -4/+15V, I_D = 20A, $R_{G(ext)}$ = 5.1Ω, L = 110μH, T_j = 25℃
Rise time	t_r	/	19	/		
Turn-off delay time	$t_{d(off)}$	/	25	/		
Fall time	t_f	/	13	/		
Turn-on switching energy	E_{on}	/	542	/	μJ	
Turn-off switching energy	E_{off}	/	78	/		
Turn-on delay time	$t_{d(on)}$	/	29	/	ns	V_{DD} = 800V, V_{GS} = -4/+15V, I_D = 20A, $R_{G(ext)}$ = 5.1Ω, L = 110μH, T_j = 175℃
Rise time	t_r	/	23	/		
Turn-off delay time	$t_{d(off)}$	/	29	/		
Fall time	t_f	/	14	/		
Turn-on switching energy	E_{on}	/	685	/	μJ	
Turn-off switching energy	E_{off}	/	81	/		

Table 6. Reverse SiC Diode Characteristics

(T_j = 25℃, unless otherwise specified)

Parameter	Symbol	Values			Unit	Test conditions
		Min.	Typ.	Max.		
Diode forward voltage	V_{SD}	/	3.5	/	V	V_{GS} = -4V, I_{SD} = 9A
		/	3.2	/		V_{GS} = -4V, I_{SD} = 9A, T_j = 175℃
Continuous diode forward current	I_S	/	/	35	A	V_{GS} = -4V, T_C = 25℃
Diode pulse current	$I_{S,\ pulse}$	/	/	88	A	V_{GS} = -4V, pulse width t_p limited by T_{jmax}
Reverse recovery time	t_{rr}	/	38	/	ns	V_{GS} = -4V, I_{SD} = 20A, V_R = 800V, T_j = 25℃ di_f/dt = 3kA/μs
Reverse recovery charge	Q_{rr}	/	0.20	/	μC	
Peak reverse recovery current	I_{rrm}	/	10	/	A	
Reverse recovery time	t_{rr}	/	42	/	ns	V_{GS} = -4V, I_{SD} = 20A, V_R = 800V, T_j = 175℃ , di_f/dt = 3kA/μs
Reverse recovery charge	Q_{rr}	/	0.42	/	μC	
Peak reverse recovery current	I_{rrm}	/	17	/	A	

Electrical Characteristic Diagrams

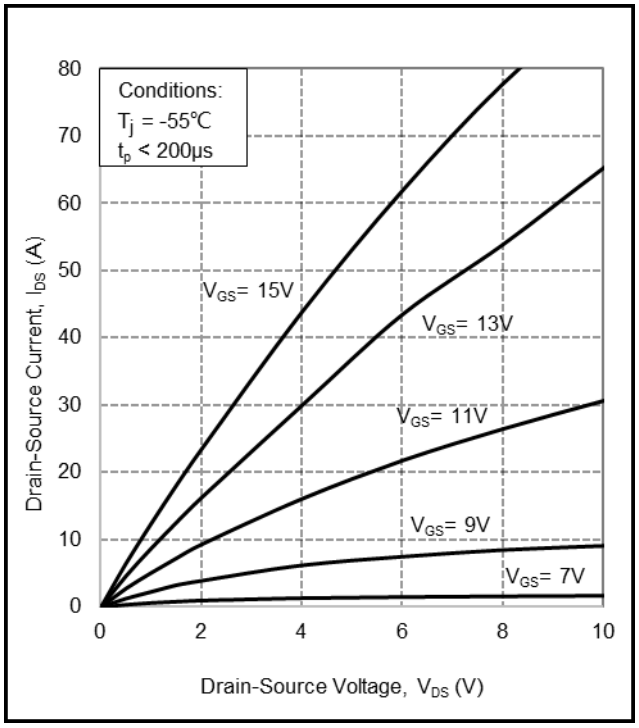


Figure 1. Output characteristics at T_j = -55℃

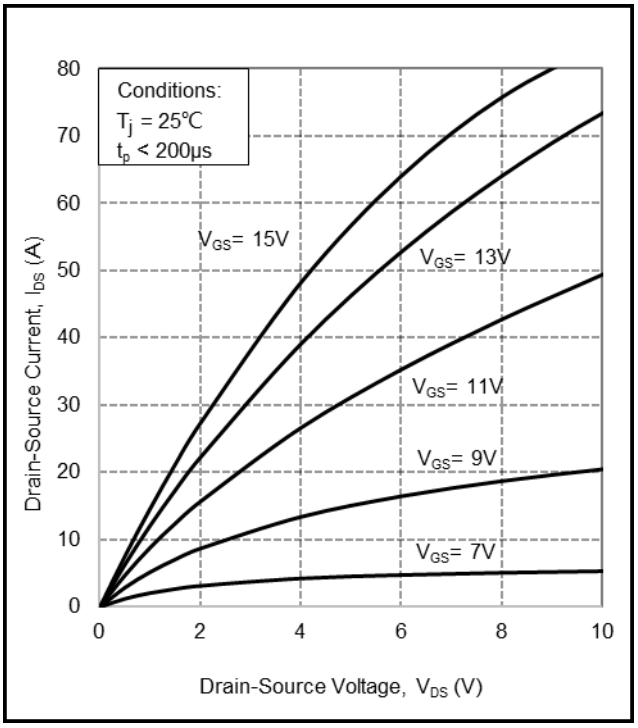


Figure 2. Output characteristics at T_j = 25℃

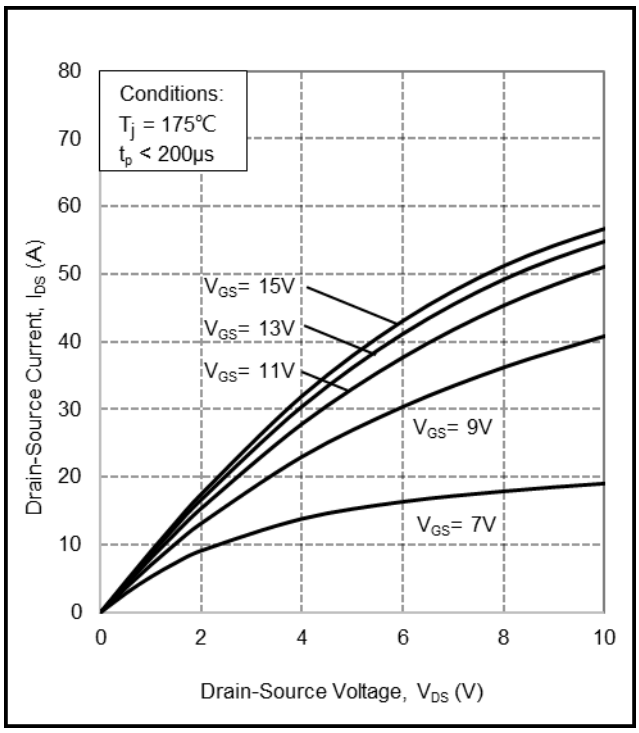


Figure 3. Output characteristics at T_j = 175℃

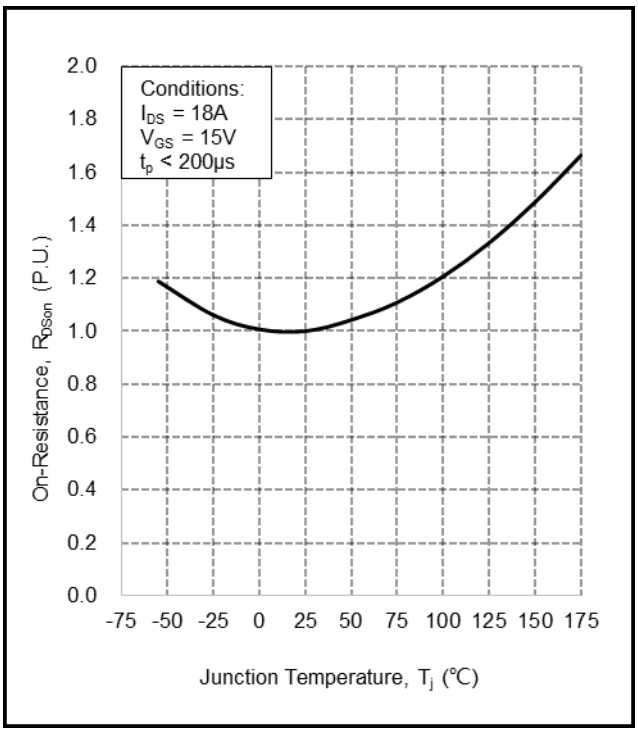


Figure 4. Normalized on-resistance vs. temperature

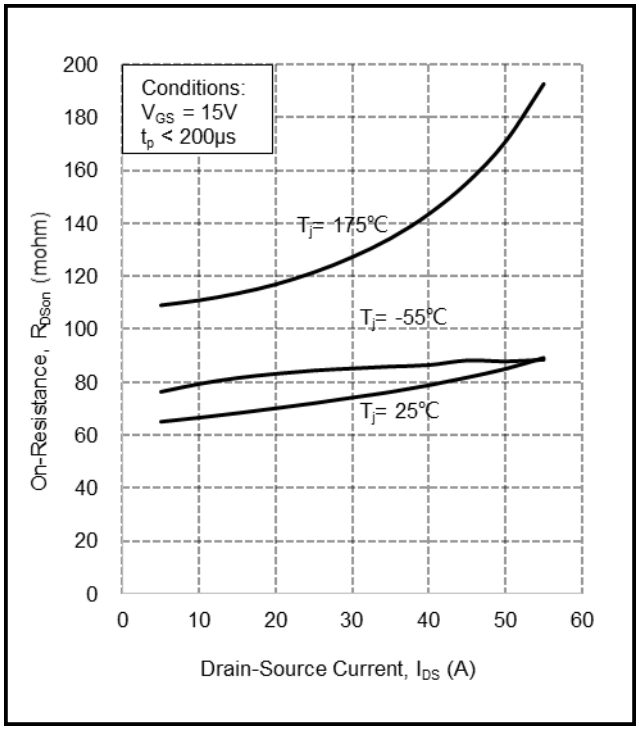


Figure 5. On-resistance vs. drain current for various temperatures

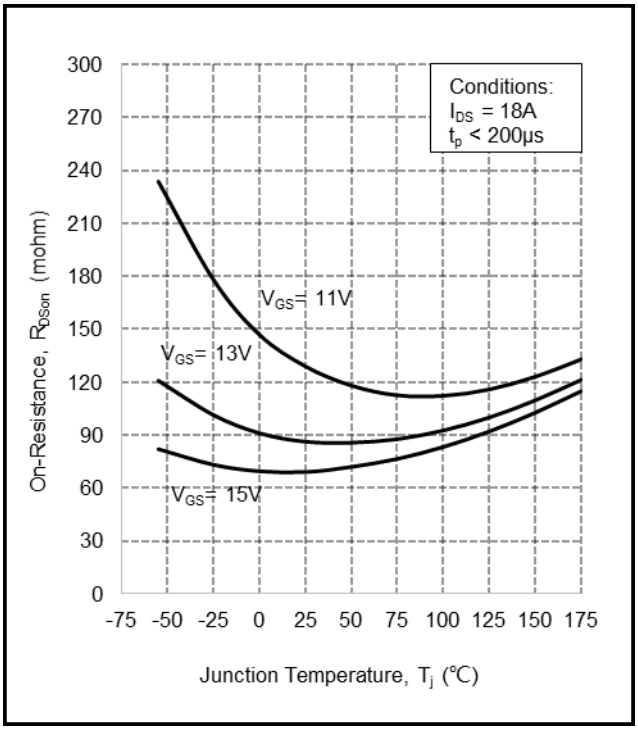


Figure 6. On-resistance vs. temperature for various gate voltages

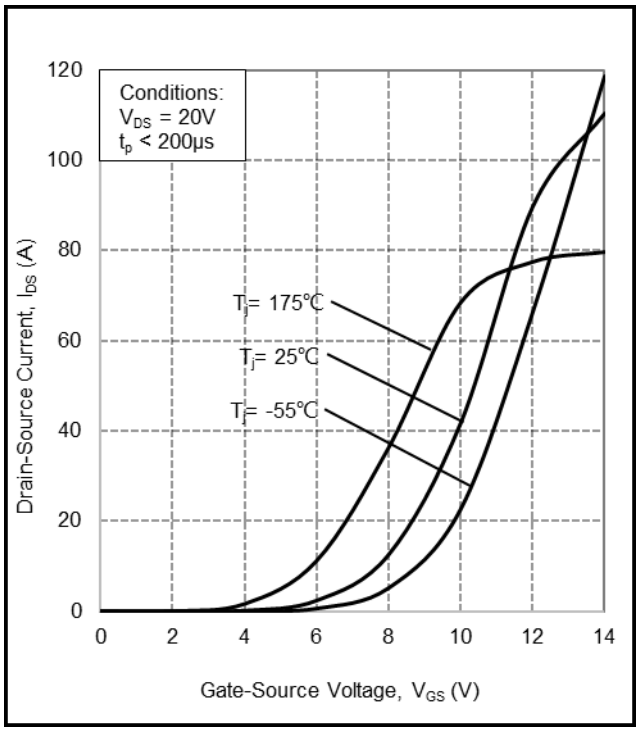


Figure 7. Transfer characteristic for various junction temperatures

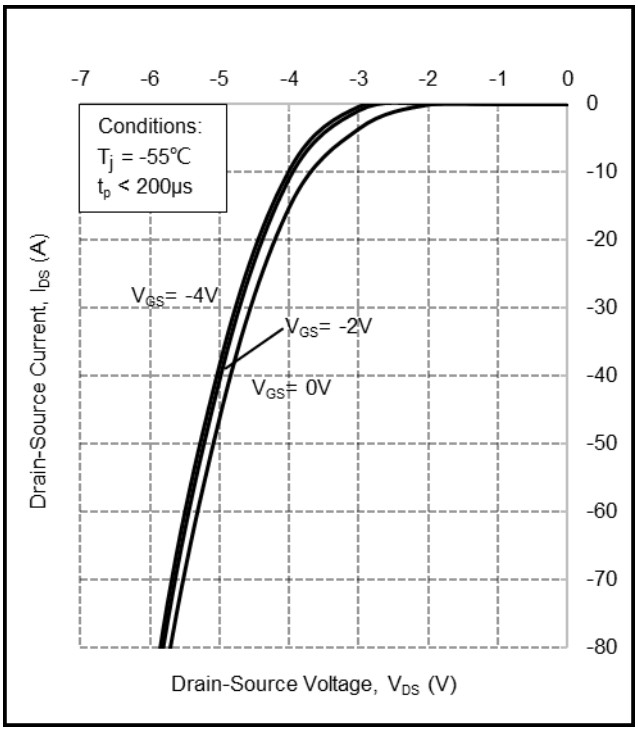


Figure 8. Body diode characteristic at T_j = -55℃

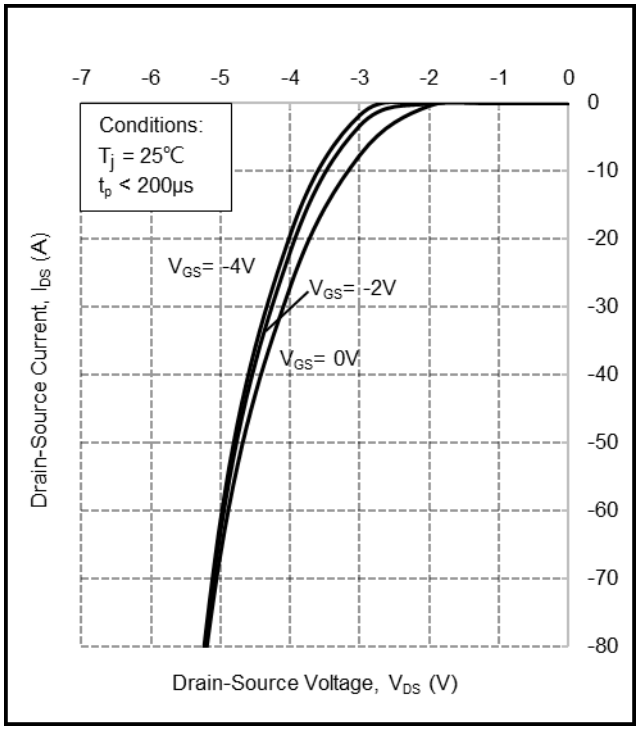


Figure 9. Body diode characteristic at T_j = 25℃

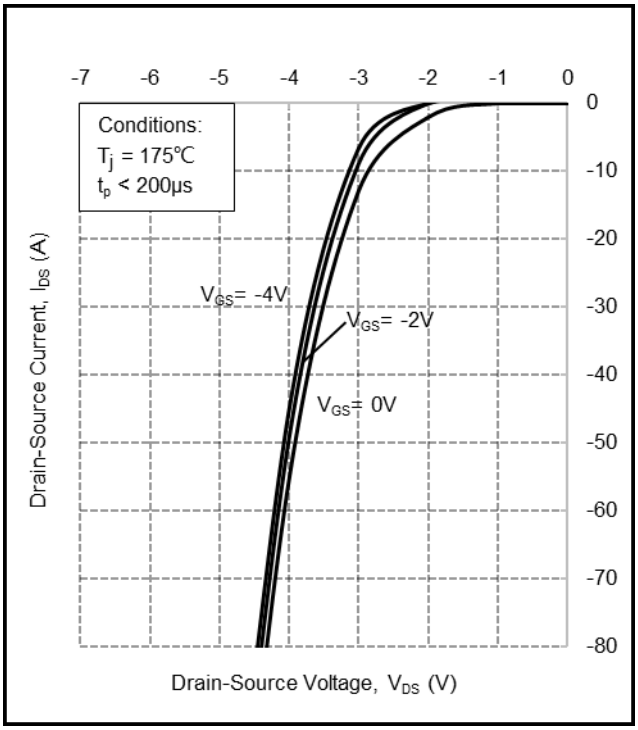


Figure 10. Body diode characteristic at T_j = 175℃

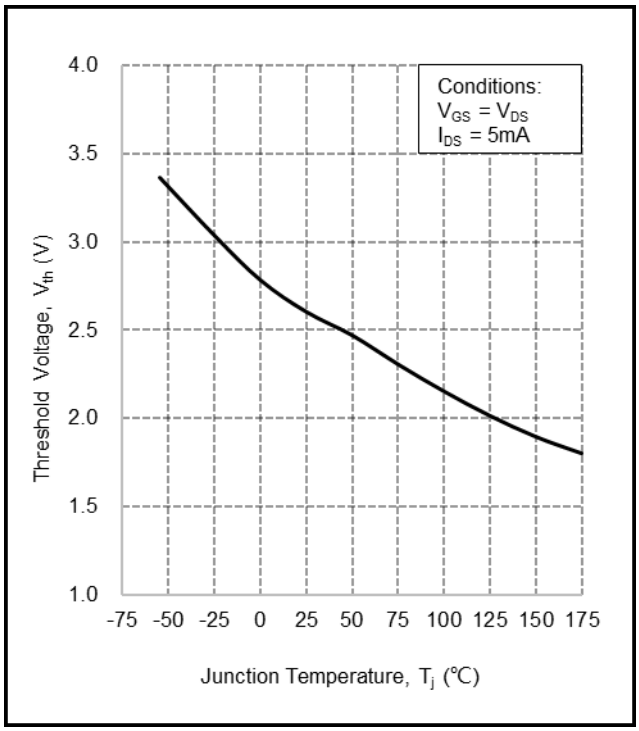


Figure 11. Threshold voltage vs. temperature

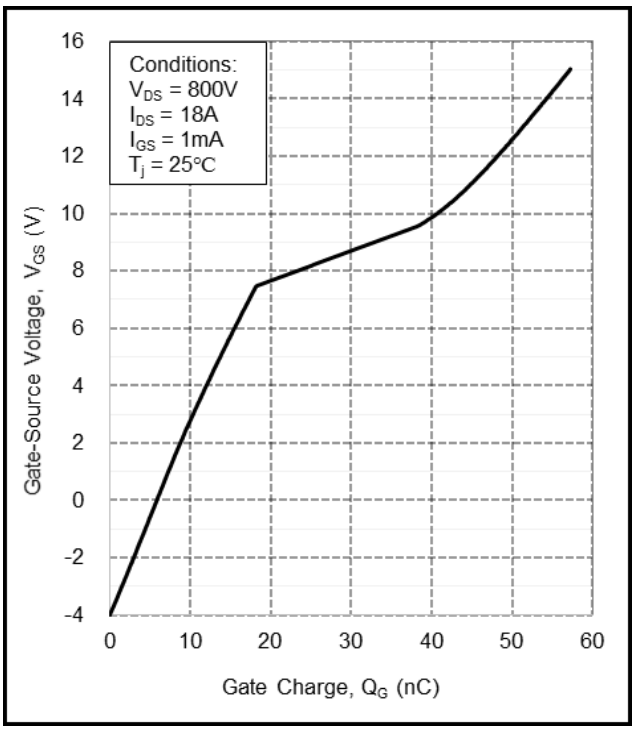


Figure 12. Gate charge characteristics

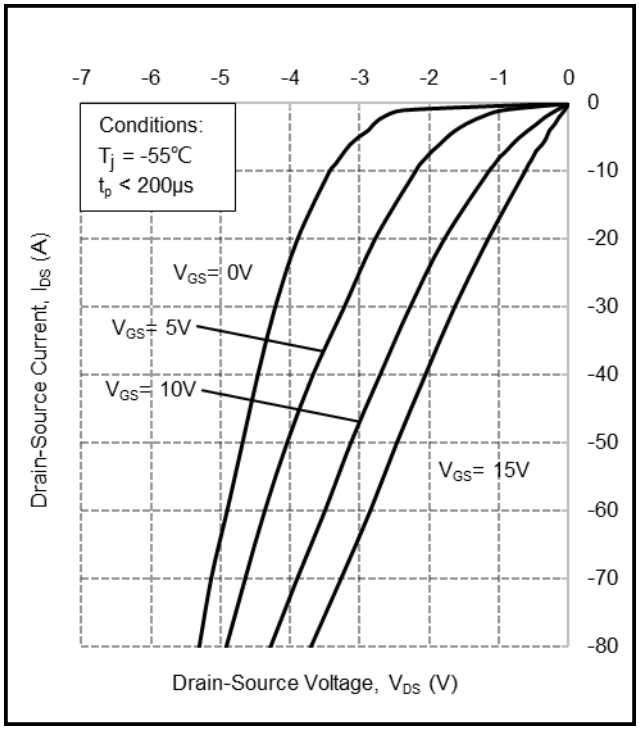


Figure 13. 3rd quadrant characteristic at T_j = -55℃

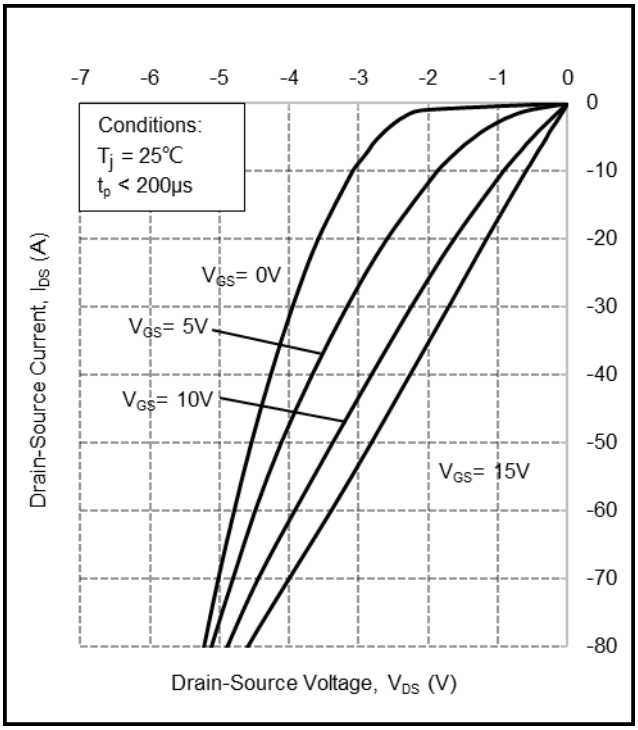


Figure 14. 3rd quadrant characteristic at T_j = 25℃

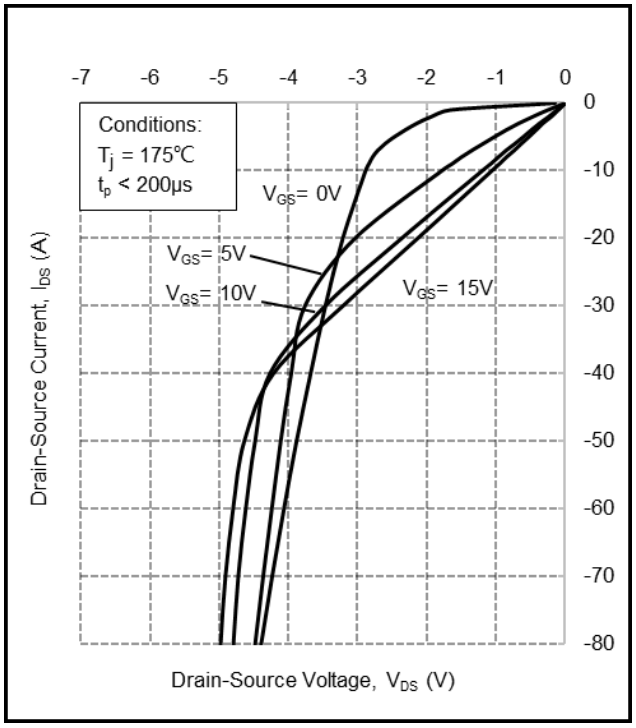


Figure 15. 3rd quadrant characteristic at T_j = 175℃

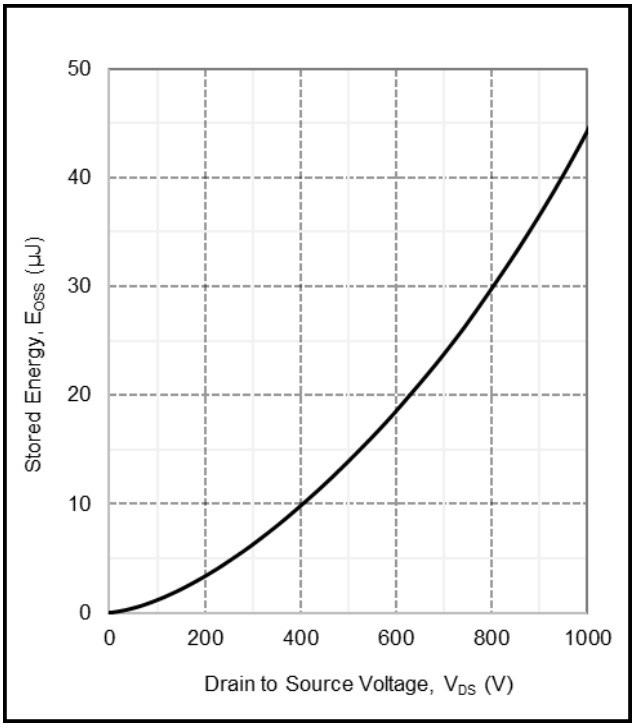


Figure 16. Output capacitor stored energy

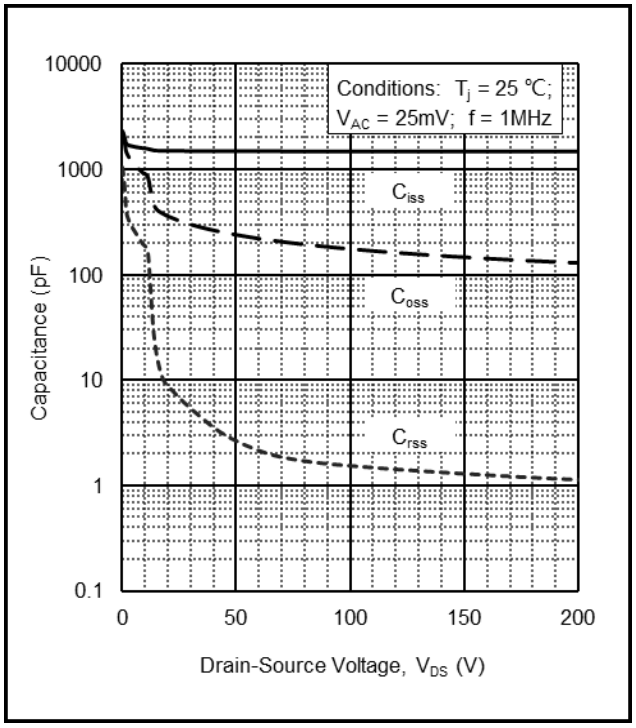


Figure 17. Capacitance vs. drain-source voltage (0 - 200V)

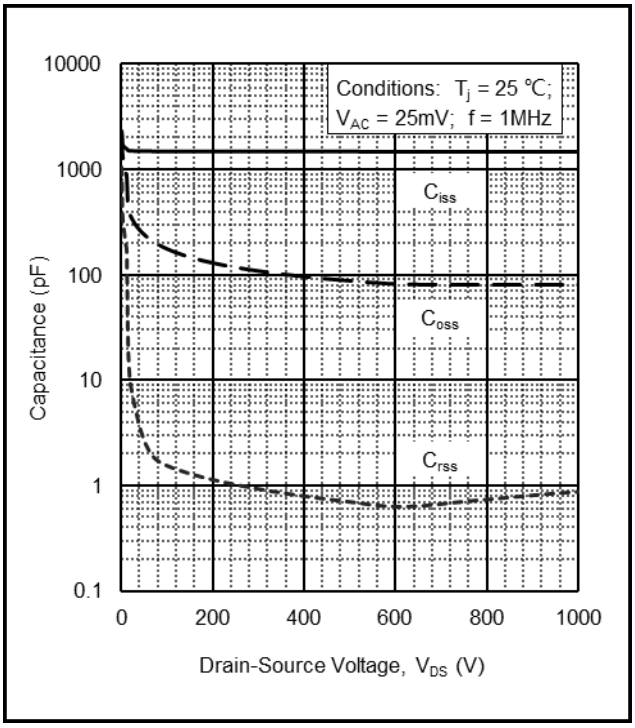


Figure 18. Capacitance vs. drain-source voltage (0 - 1000V)

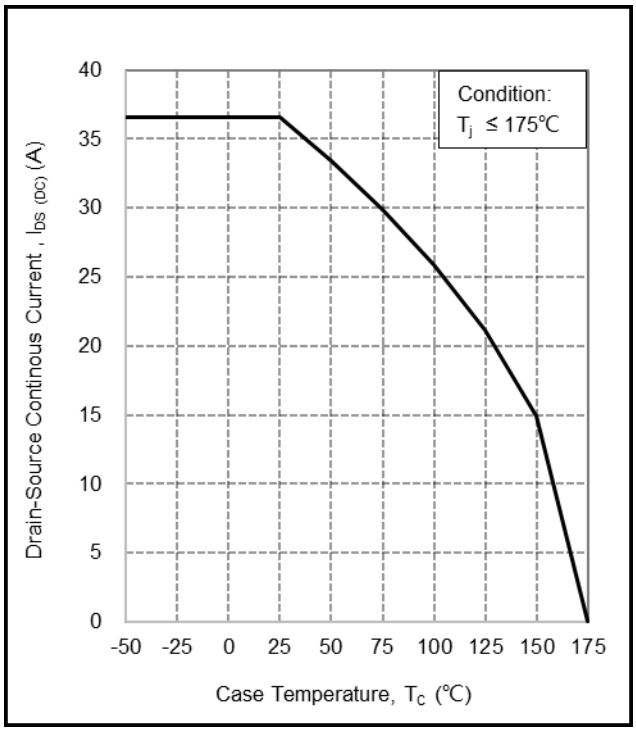


Figure 19. Continuous drain current derating vs. temperature

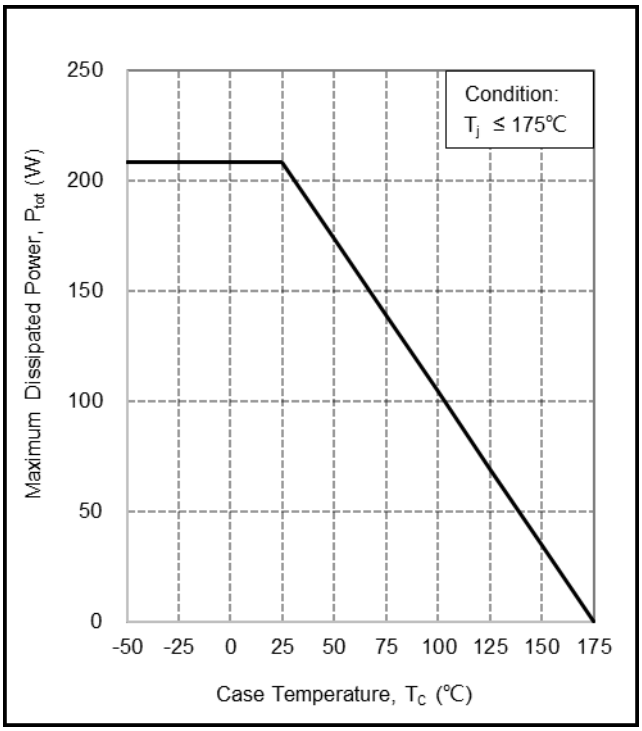


Figure 20. Maximum power dissipation derating vs. temperature

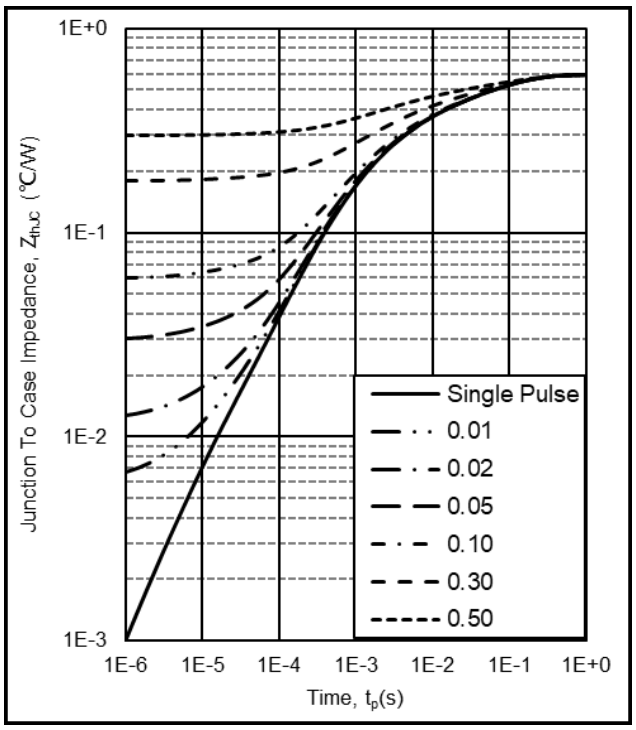


Figure 21. Transient thermal impedance (Junction - Case)

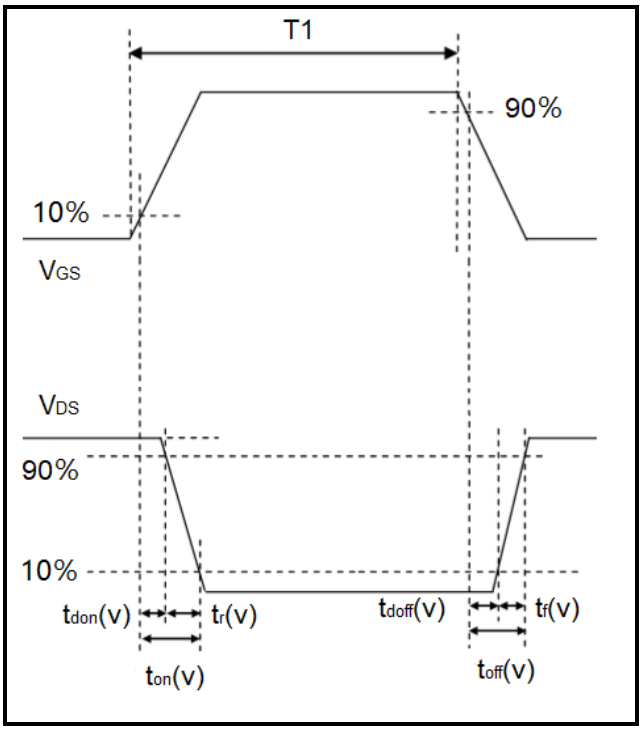


Figure 22. Switching times definition

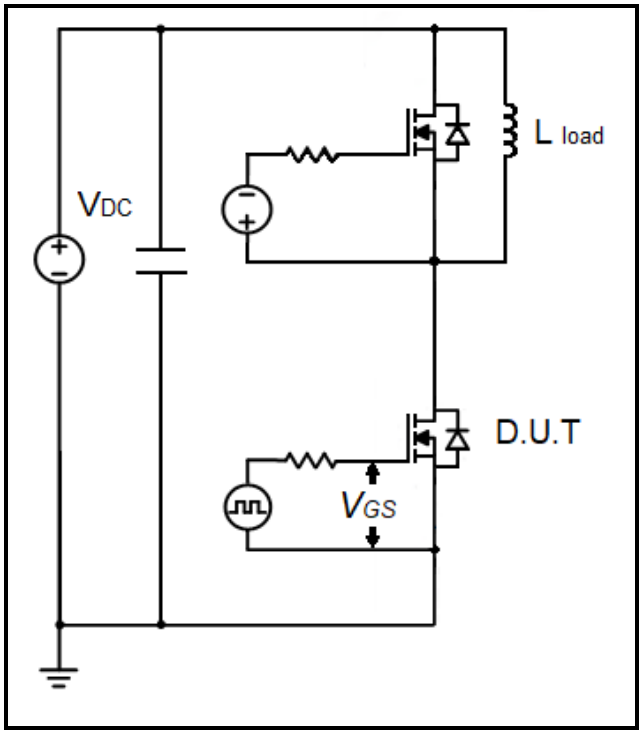
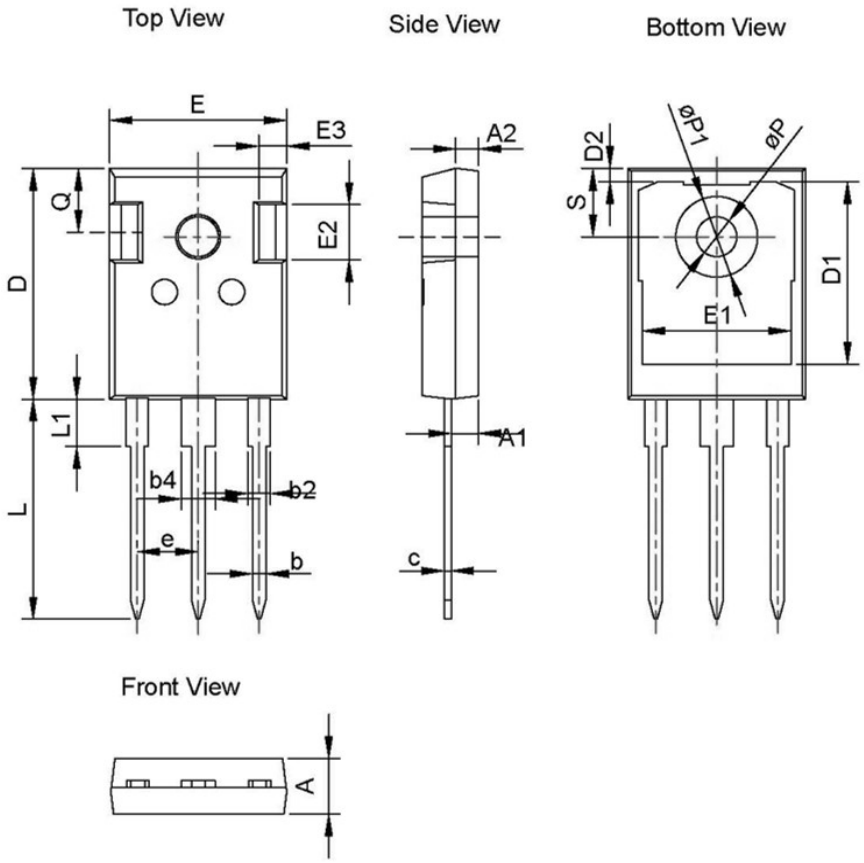


Figure 23. Clamped inductive switching waveform test circuit

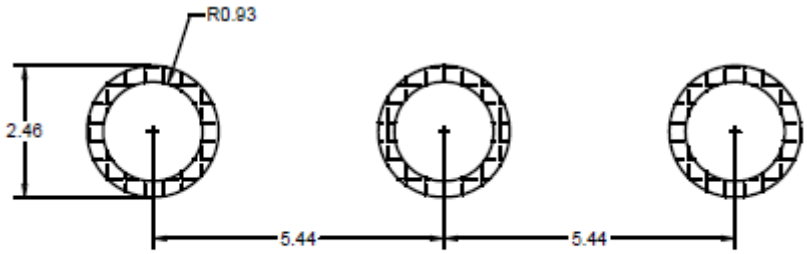
Package Information



Dimension unit: [mm]			
Symbol	Min	Nom	Max
A	4.80	5.00	5.20
A1	2.21	2.41	2.61
A2	1.85	2.00	2.15
b	1.11	1.21	1.36
b2	1.91	2.01	2.21
b4	2.91	3.01	3.21
c	0.51	0.60	0.75
D	20.70	21.00	21.30
D1	16.25	16.55	16.85
D2	1.00	1.20	1.35
E	15.50	15.80	16.10
E1	13.00	13.30	13.60
E2	4.80	5.00	5.20
E3	2.30	2.50	2.70
e	5.44 BSC		
L	19.62	19.92	20.22
L1	-	-	4.30
øP	3.40	3.60	3.80
øP1	-	-	7.30
Q	5.40	5.80	6.20
S	6.20 BSC		

Recommended Solder Pad Layout

Note: All dimensions are in mm



TO-247-3L

Ordering Information

Part number	AMS1200075K-ASATH
Package	TO-247-3L
Unit quantity	300 EA
Packing type	Tube

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